

Molecular Dynamics Simulation of Thin Films with Rough and Asymmetric Interfaces

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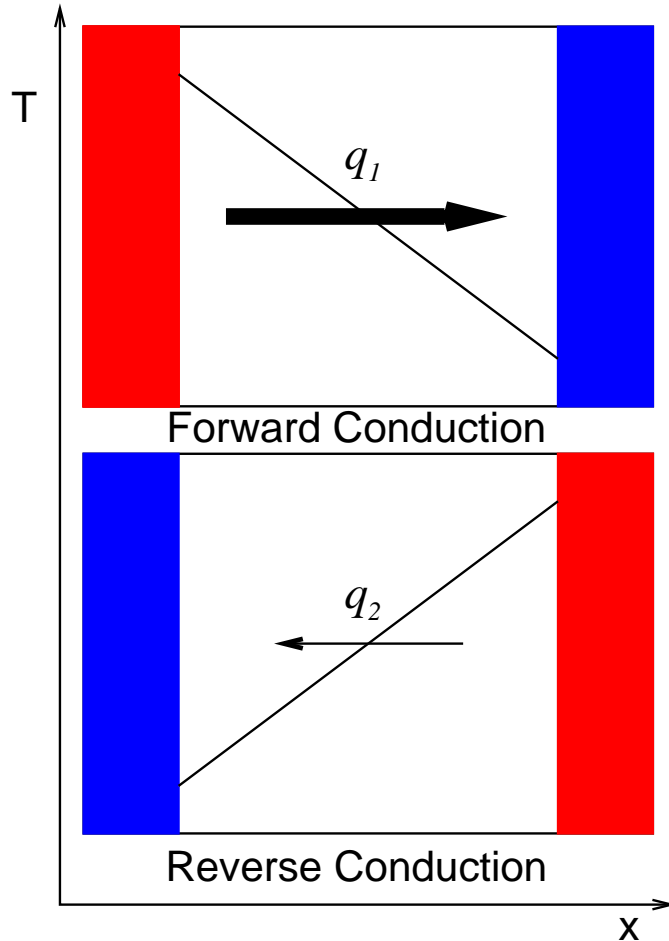
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Thermal rectification is a phenomenon where transport through a device is dependent on direction



$$q = -kA \frac{dT}{dx}$$

$$q_1 > q_2$$

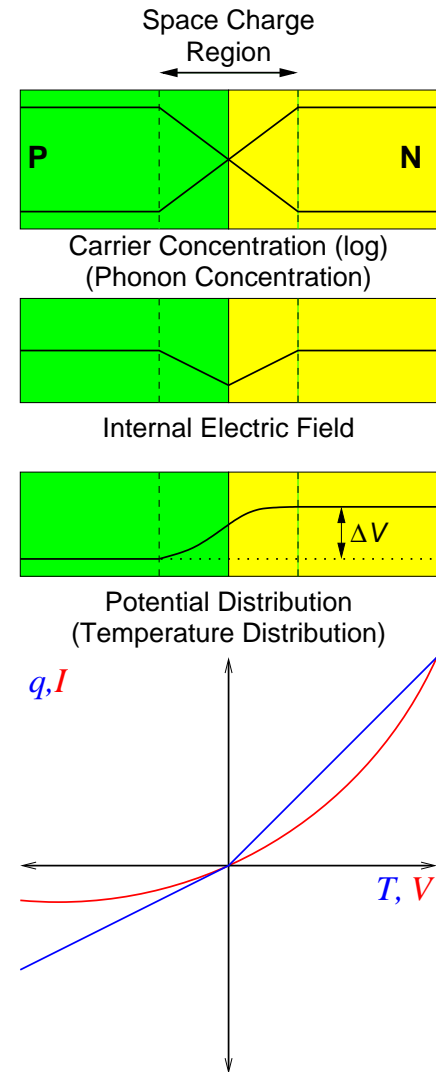
$$k_1 > k_2$$

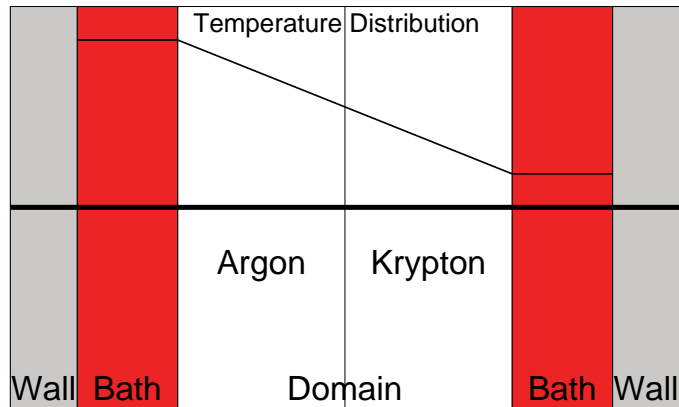
- Widespread applications in thermal management problems
 - Cooling of micro/nano electronics
 - Improvement of macroscale refrigeration and energy saving buildings

Analog to pn -junction (Diode)



- In equilibrium electrons diffuse into p -type semiconductor and holes diffuse into n -type semiconductor, this creates the space charge region and built-in potential (voltage)
- A forward bias decreases the potential across the junction which enhances transport
- A reverse bias increases the potential across the junction reduces transport resulting in minimal current flow
- Thermal rectifying behaviour should be observed if a device could be created in which phonon transport can be manipulated



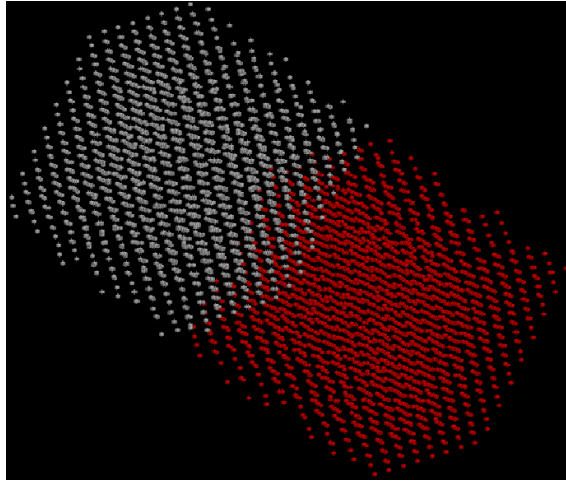


Material	Parameter	Value
Kr	$\epsilon(J)$	2.25×10^{-21}
	$\sigma(m)$	3.65×10^{-10}
	$a(m)$	5.69×10^{-10}
	$m(kg)$	1.35×10^{-25}
Ar	$\epsilon(J)$	1.67×10^{-21}
	$\sigma(m)$	3.40×10^{-10}
	$a(m)$	5.31×10^{-10}
	$m(kg)$	6.63×10^{-26}

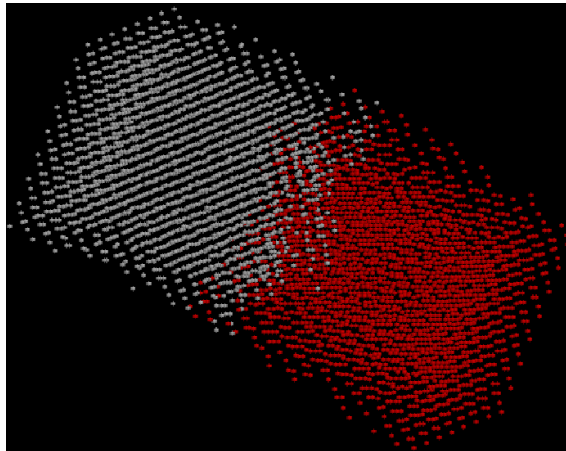
- Using XMD, open source molecular dynamics code to calculate thermal conductivity
- Argon/Krypton FCC domain, wall and bath
- Fixed position walls at boundaries orthogonal to transport and periodic boundaries parallel to transport
- Baths are held at a constant temperature
- Records energy added/subtracted from baths each 100 steps

$$U(r_{ij}) = 4\epsilon \left[\left(\frac{\sigma}{r} \right)^{12} - \left(\frac{\sigma}{r} \right)^6 \right]$$

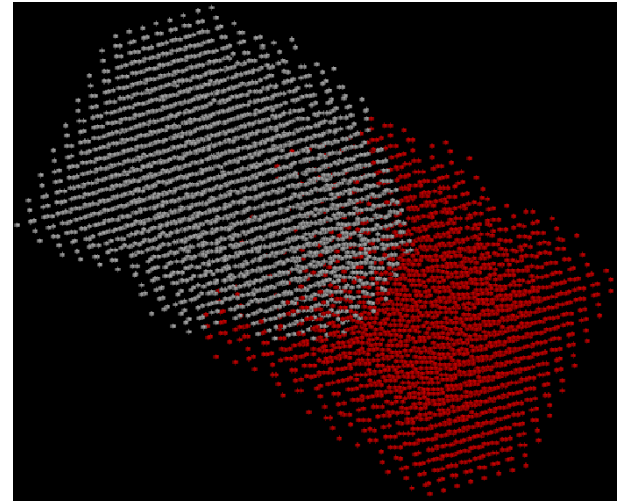
$$q = -kA \frac{\Delta T}{L}$$



Perfect Interface



Diffuse Interface



Asymmetrical Interface

- $8 \times 8 \text{ UC}^2$ FCC domain cross-sections
- 8 – 96 UC lengths
- Equal amounts of Argon and Krypton
 - Argon - Gray
 - Krypton - Red

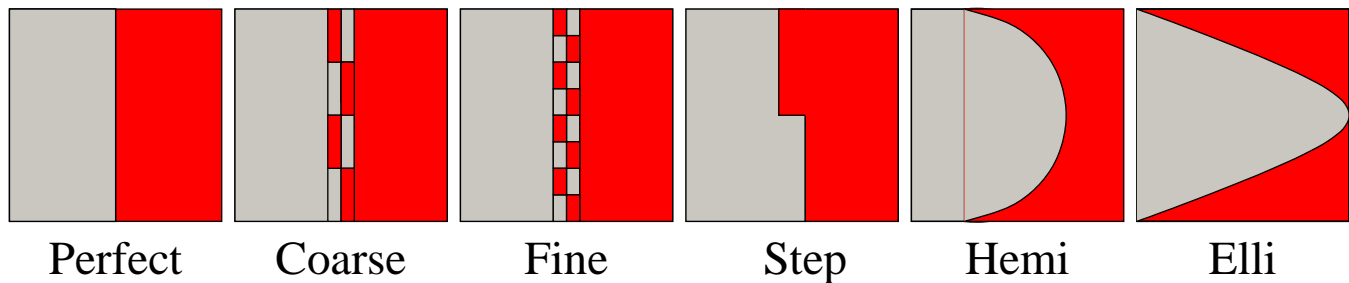
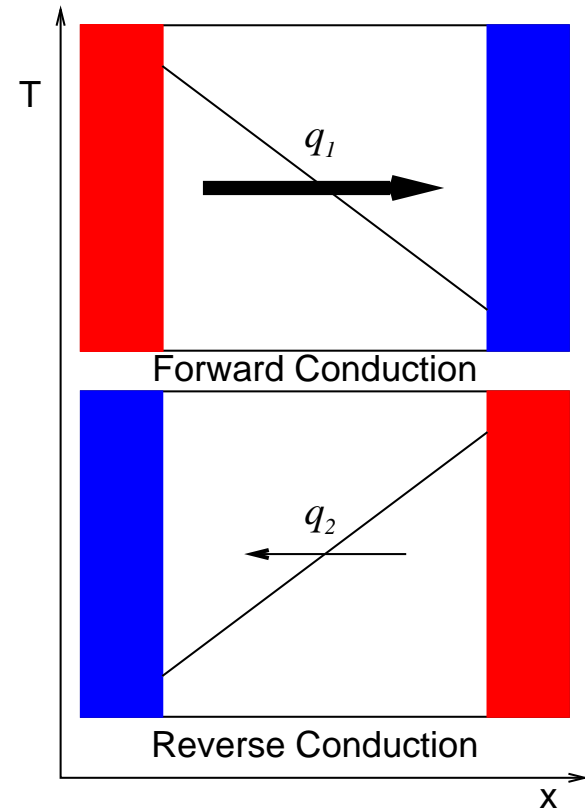
Determination of Thermal Rectification



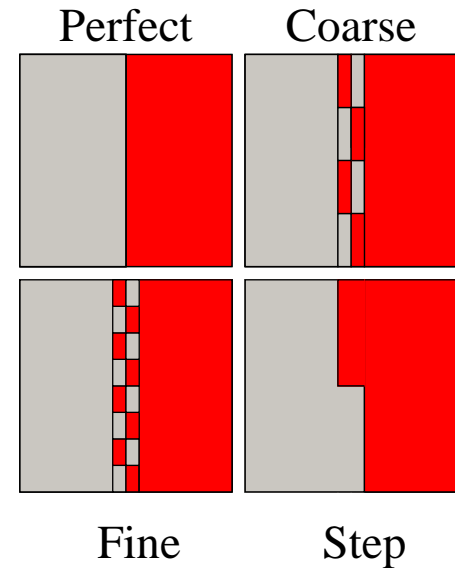
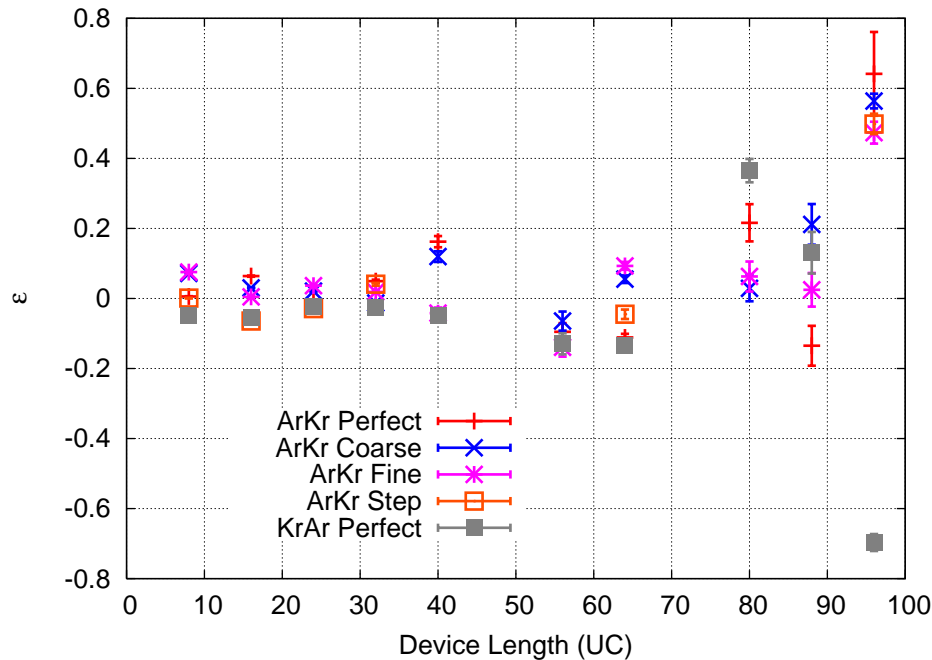
- Apply temperature gradient and allow simulation to run to steady-state, calculate thermal conductivity
- Reverse temperature gradient and allow simulation to run, calculate thermal conductivity

$$\epsilon = \frac{k^+ - k^-}{k^-}$$

- Simulations were run up to 4.8 ns to obtain averaged values of thermal conductivity.

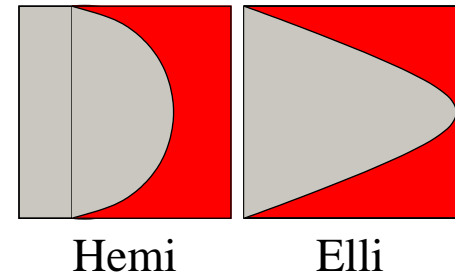
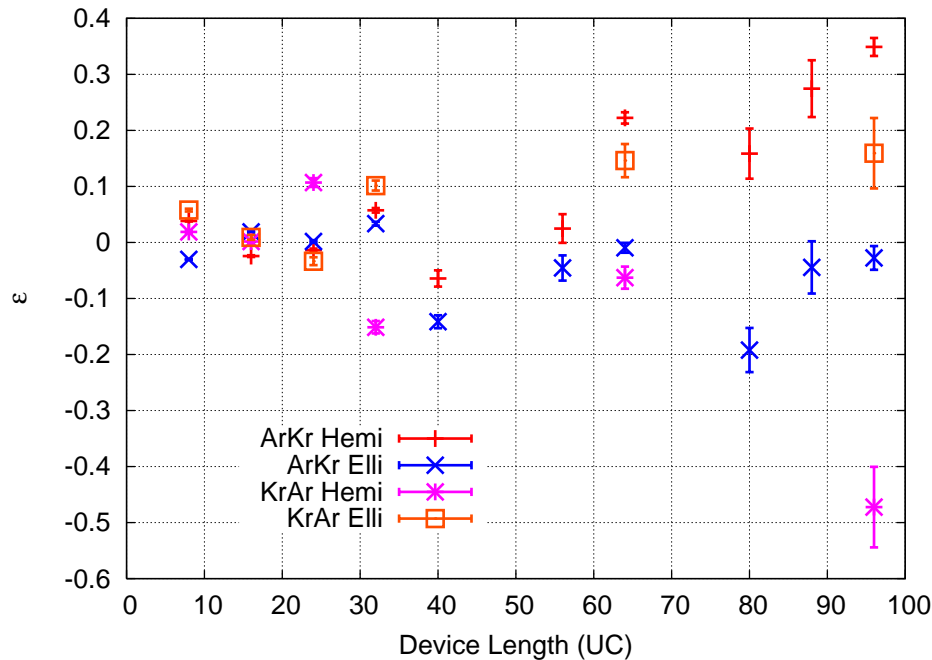


Simulation Results - Interface Rectification



- Rectification occurs in longer devices
- Transport preferred from argon to krypton (soft, light material to stiff, heavy material)
- No noticeable difference in rectifying behavior between different interfaces

Simulation Results - Asymmetric Rectification



Hemi

Elli

- Rectification occurs in longer hemispherical devices
- Transport preferred from argon to krypton (soft, light material to stiff, heavy material)
- Ellipsoidal interface results in very little rectification (very poor rectifying interface)

Conclusions



- Greatest rectification in perfect and imperfect interfaces (no difference between them)
- Transport preferred from argon (soft and light) to krypton (stiff and heavy) due to the difference in frequency content
- Asymmetry is a form of interface degradation
- Rectification due to interfaces should be present in devices with materials with different frequency content when the interface is designed to selectively scatter specific phonon frequencies